

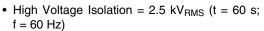
## SSS2N90-VB Datasheet

## N-Channel 950 V (D-S) Power MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	95	50		
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	3.5		
Q <sub>g</sub> (Max.) (nC)	78	1		
Q <sub>gs</sub> (nC)	10	1		
Q <sub>gd</sub> (nC)	42			
Configuration	Sing	Single		

#### **FEATURES**

· Isolated Package

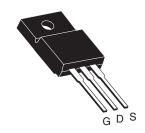


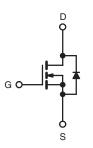


- Sink to Lead Creepage Distance = 4.8 mm
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available









N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T	<sub>C</sub> = 25 °C, unless otherw	rise noted			
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		$V_{DS}$	950	V	
Gate-Source Voltage		$V_{GS}$	± 20	\ \ \	
Continuous Drain Current	V <sub>GS</sub> at 10 V T <sub>C</sub> = 25 °C	I_	3.0		
Continuous Diam Current	$T_C = 100 ^{\circ}C$	I <sub>D</sub>	2.3	Α	
Pulsed Drain Current <sup>a</sup>	$I_{DM}$	10			
Linear Derating Factor			0.28	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	220	mJ	
Repetitive Avalanche Currenta		$I_{AR}$	1.9	Α	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	3.5	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	$P_{D}$	35	W	
Peak Diode Recovery dV/dtc		dV/dt	1.5	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	7	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF MIS SCIEW		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=50~V$ , starting  $T_J=25~^{\circ}C$ ,  $L=115~^{\circ}MH$ ,  $R_G=25~^{\circ}\Omega$ ,  $I_{AS}=1.9~A$  (see fig. 12). c.  $I_{SD}\leq 3.6~A$ ,  $dI/dt\leq 70~A/\mu s$ ,  $V_{DD}\leq 600$ ,  $T_J\leq 150~^{\circ}C$ .

- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	65	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.6	C/VV

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		•					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		950	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		1.1	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zone Cata Valtaga Duais Commant		V <sub>DS</sub> = 900 V, V <sub>GS</sub> = 0 V		-	-	100	μΑ
Zero Gate Voltage Drain Current	$V_{DS} = 720 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$		/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 1.1 A <sup>b</sup>	-	3.5	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> :	= 50 V, I <sub>D</sub> = 1.1 A <sup>b</sup>	1.7	-	-	S
Dynamic		•					
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V}, \\ V_{DS} = 25 \text{ V},$		-	1200	-	
Output Capacitance	C <sub>oss</sub>			-	320	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	200	-	pF
Drain to Sink Capacitance	С	f = 1.0 MHz		-	12	-	1
Total Gate Charge	Qg			-	-	78	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 3.6 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and $13^b$	-	-	10	nC
Gate-Drain Charge	Q <sub>gd</sub>	1	See lig. 6 and 16	-	-	42	
Turn-On Delay Time	t <sub>d(on)</sub>			-	14	-	
Rise Time	t <sub>r</sub>		450 V, I <sub>D</sub> = 3.6 A,	-	25	-	]
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G = 12 \Omega, R_D = 120 \Omega,$ see fig. $10^b$		-	90	-	ns
Fall Time	t <sub>f</sub>			-	30	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	•					
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.9	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	7.6	A
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C	$I_{S}$ , $I_{S}$ = 1.9 A, $V_{GS}$ = 0 $V^{b}$	-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 25 °C 1	- 26 A dl/dt - 100 A/vah	-	430	650	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 3.6  \text{A},  \text{dI/dt} = 100  \text{A/}\mu\text{s}^{\text{b}}$		-	1.4	2.1	μС
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					L <sub>D</sub> )

#### Notes

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- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

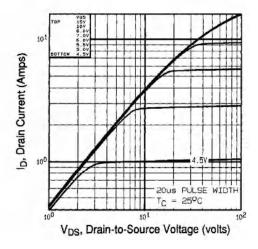


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

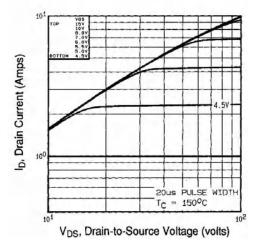


Fig. 2 - Typical Output Characteristics,  $T_C = 150 \, ^{\circ}C$ 

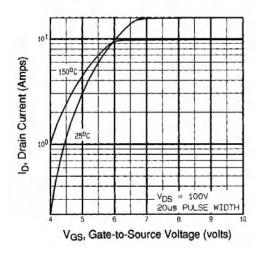


Fig. 3 - Typical Transfer Characteristics

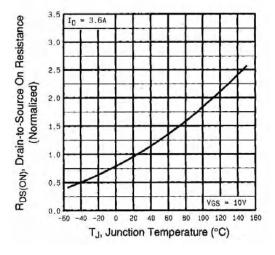


Fig. 4 - Normalized On-Resistance vs. Temperature



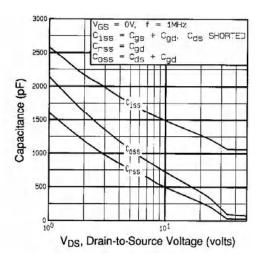


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

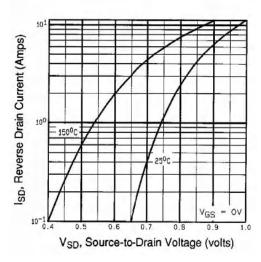


Fig. 7 - Typical Source-Drain Diode Forward Voltage

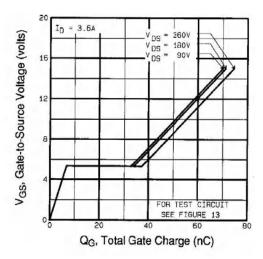


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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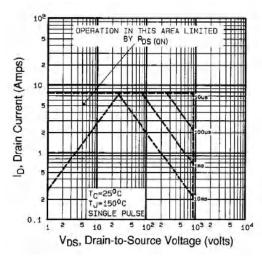


Fig. 8 - Maximum Safe Operating Area



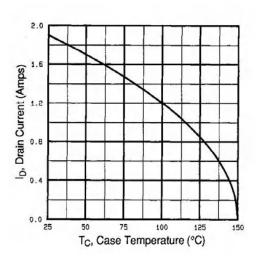


Fig. 9 - Maximum Drain Current vs. Case Temperature

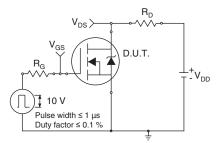


Fig. 10a - Switching Time Test Circuit

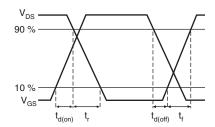


Fig. 10b - Switching Time Waveforms

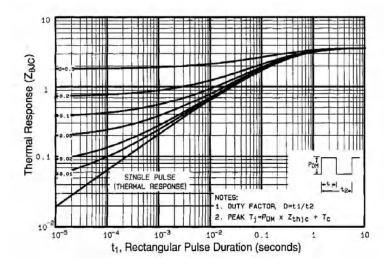


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

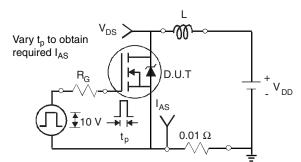


Fig. 12a - Unclamped Inductive Test Circuit

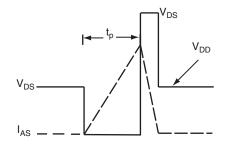


Fig. 12b - Unclamped Inductive Waveforms



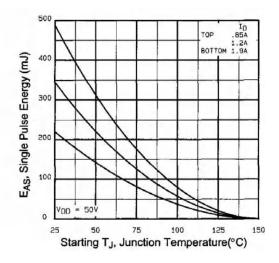


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

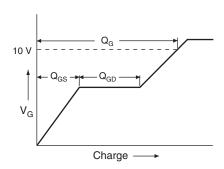


Fig. 13a - Basic Gate Charge Waveform

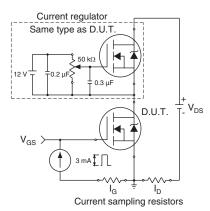
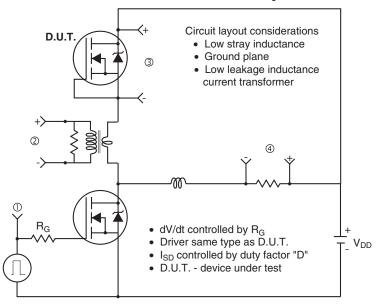


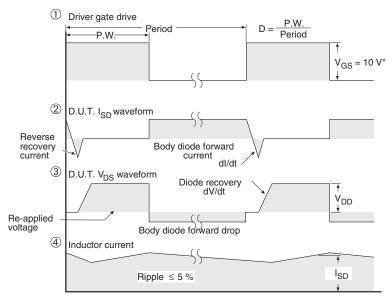
Fig. 13b - Gate Charge Test Circuit



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## Peak Diode Recovery dV/dt Test Circuit



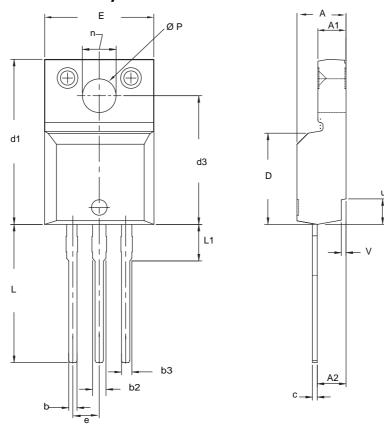


\*  $V_{GS} = 5 V$  for logic level devices

Fig.14 - For N-Channel



## **TO-220 FULLPAK (HIGH VOLTAGE)**



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54 BSC		0.100	BSC
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØΡ	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
٧	0.400	0.500	0.016	0.020

ECN: X09-0126-Rev. B, 26-Oct-09 DWG: 5972

#### Notes

- To be used only for process drawing.
  These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
  All critical dimensions should C meet C<sub>pk</sub> > 1.33.
  All dimensions include burst and plating thickness.

- 5. No chipping or package damage.



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